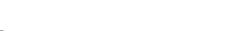


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent Under Reexamination
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<b>Examiner</b> HENG CHAN	Art Unit	
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/HENG CHAN/ Examiner.Art Unit 1728		09/14/2011	<b>Total Claims Allowed:</b>	
(Assistant Examiner)	(Date)		14	
/JENNIFER MICHENER/ Supervisory Patent Examiner.Art Unit 1728		09/16/2011	O.G. Print Claim(s)	O.G. Print Figure
(Primary Examiner)	(Date)		1	N/A